

**Notice of References Cited**

 Application/Control No.  
 09/842,436

 Applicant(s)/Patent Under  
 Reexamination  
 CHAPMAN ET AL.

 Examiner  
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 2625

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,177,682 B1	01-2001	Bartulovic et al.	250/559.44
	B	US-5,943,125	08-1999	King et al.	356/237.1
	C	US-5,949,901	09-1999	Nichani et al.	382/149
	D	US-5,774,574	06-1998	Hoki, Tetsuo	382/149
	E	US-5,920,387	07-1999	Nakajo et al.	356/237.4
	F	US-5,859,698	01-1999	Chau et al.	356/237.2
	G	US-6,658,144 B1	12-2003	Hatab, Ziad R.	382/144
	H	US-6,353,222 B1	03-2002	Dotan, Noam	250/310
	I	US-6,256,088 B1	07-2001	Gordon, John Francis	356/73
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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